

2SB0745, 2SB0745A (2SB745, 2SB745A)

Silicon PNP epitaxial planar type

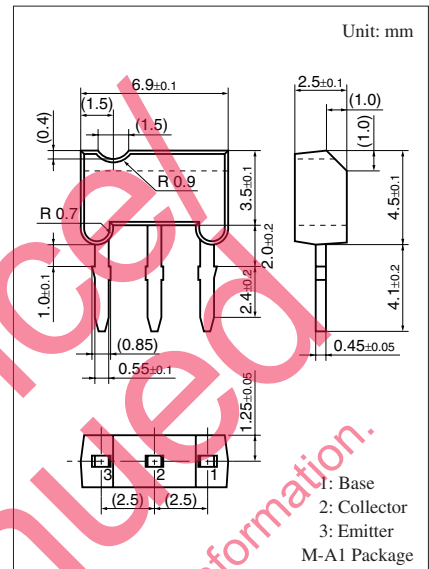
For low-frequency and low-noise amplification

■ Features

- Low noise voltage NV
- High forward current transfer ratio h_{FE}
- M type package allowing easy automatic and manual insertion as well as stand-alone fixing to the printed circuit board.

■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit
Collector-base voltage (Emitter open)	2SB0745	-35	V
	2SB0745A	-55	
Collector-emitter voltage (Base open)	2SB0745	-35	V
	2SB0745A	-55	
Emitter-base voltage (Collector open)	V_{EBO}	-5	V
Collector current	I_C	-50	mA
Peak collector current	I_{CP}	-200	mA
Collector power dissipation	P_C	400	mW
Junction temperature	T_j	150	$^\circ\text{C}$
Storage temperature	T_{stg}	-55 to +150	$^\circ\text{C}$



■ Electrical Characteristics $T_a = 25^\circ\text{C} \pm 3^\circ\text{C}$

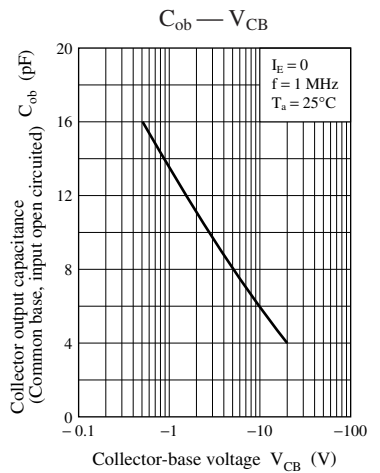
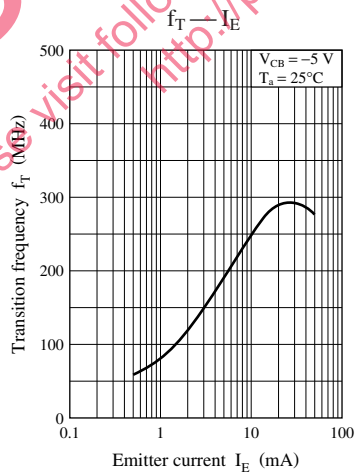
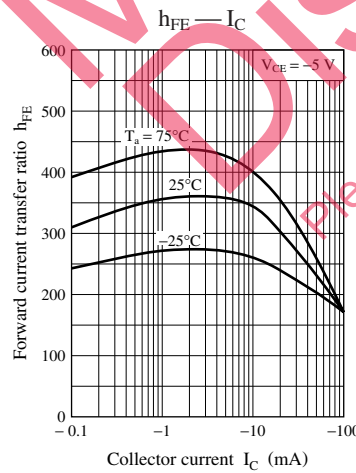
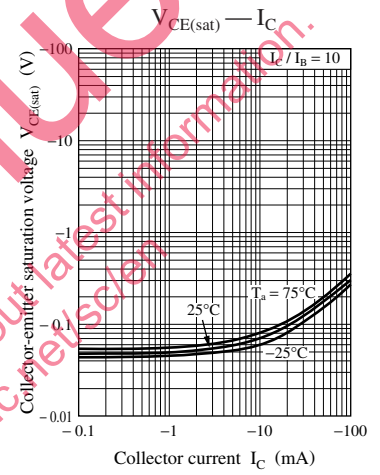
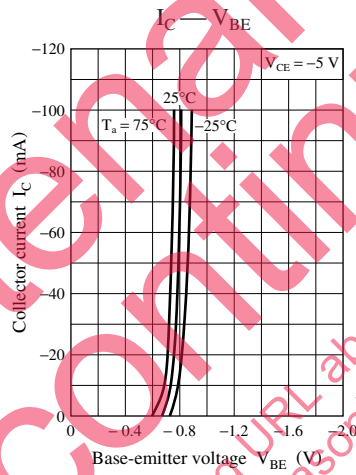
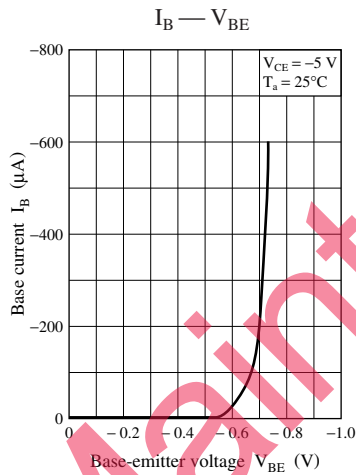
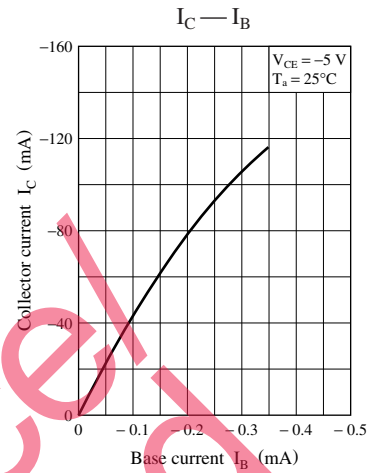
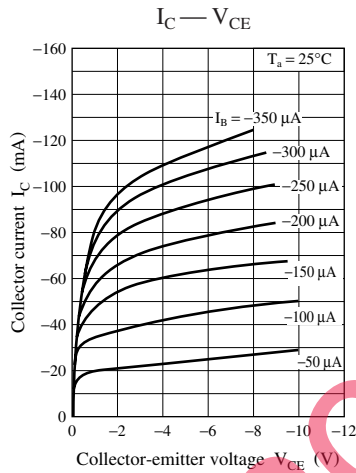
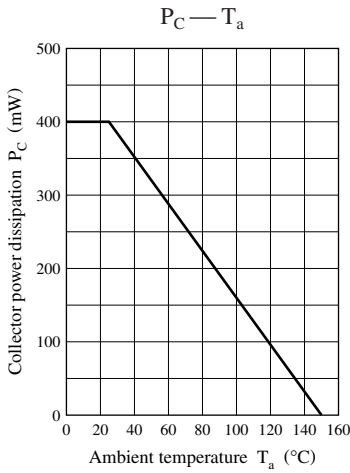
Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Collector-base voltage (Emitter open)	2SB0745	$I_C = -10 \mu\text{A}, I_E = 0$	-35			V
	2SB0745A		-55			
Collector-emitter voltage (Base open)	2SB0745	$I_C = -2 \text{ mA}, I_B = 0$	-35			V
	2SB0745A		-55			
Emitter-base voltage (Collector open)	V_{EBO}	$I_E = -10 \mu\text{A}, I_C = 0$	-5			V
Base-emitter voltage	V_{BE}	$V_{CE} = -1 \text{ V}, I_C = -100 \text{ mA}$		-0.7	-1.0	V
Collector-base cutoff current (Emitter open)	I_{CBO}	$V_{CB} = -10 \text{ V}, I_E = 0$			-0.1	μA
Collector-emitter cutoff current (Base open)	I_{CEO}	$V_{CE} = -10 \text{ V}, I_B = 0$			-1	μA
Forward current transfer ratio *	h_{FE}	$V_{CE} = -5 \text{ V}, I_C = -2 \text{ mA}$	180		700	—
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_C = -100 \text{ mA}, I_B = -10 \text{ mA}$			-0.6	V
Transition frequency	f_T	$V_{CB} = -5 \text{ V}, I_E = 2 \text{ mA}, f = 200 \text{ MHz}$		150		MHz
Noise voltage	NV	$V_{CE} = -10 \text{ V}, I_C = -1 \text{ mA}, G_V = 80 \text{ dB}$ $R_g = 100 \text{ k}\Omega, \text{Function} = \text{FLAT}$			150	mV

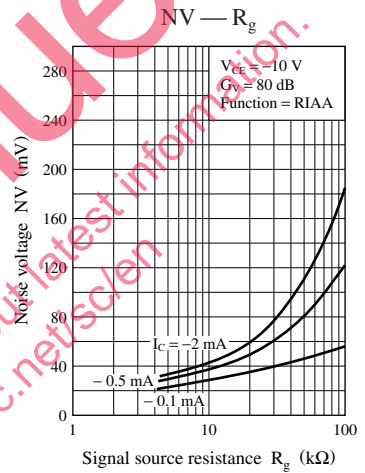
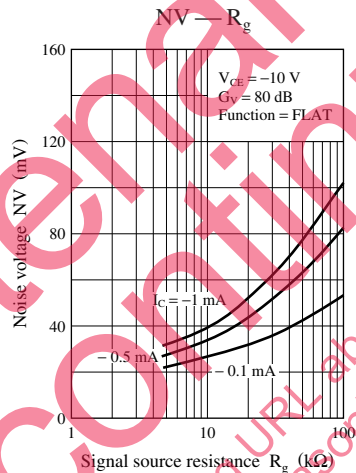
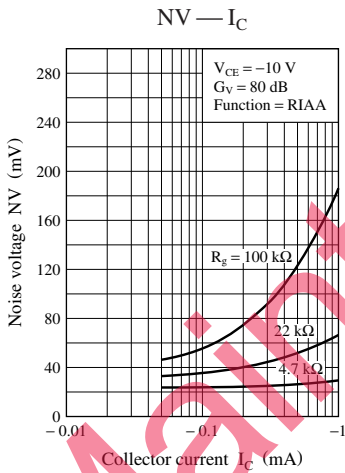
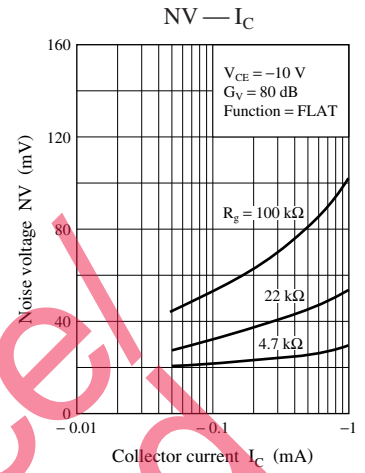
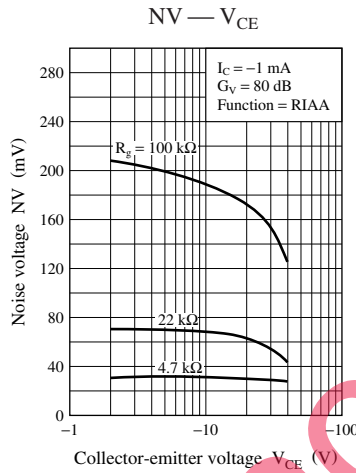
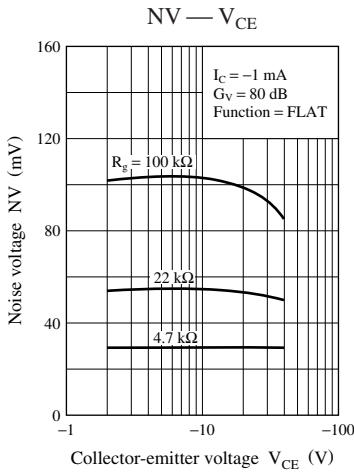
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

2. *: Rank classification

Rank	Q	R	S
h_{FE}	180 to 360	260 to 520	360 to 700

Note) The part numbers in the parenthesis show conventional part number.





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